Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10540640	FUJIMURA ET AL.
Examiner	Art Unit

1794

SEARCHED				
Class	Subclass	Date	Examiner	
427	70,116,177,248.1,249.8,577 updated	10/2008	AAT	
428	446,408 updated	1/20080	AAT	

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SEARCH NOTES		
Date	Examiner	

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

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